

Applicant: Toshikazu Hasimoto et al.

Confirmation No.: 9162

Serial No.: 10/540,734

Att'y Docket No.: 14321.78

Filing Date: January 23, 2006

Art Unit: 2874

For: WAVE TRANSMISSION MEDIUM AND WAVEGUIDE CIRCUIT

SECOND SUPPLEMENTAL INFORMATION DISCLOSURE CITATIONS MADE BY APPLICANTU.S. Patent Documents

<u>Examiner Initial*</u>	<u>Document Number</u>	<u>Issue Date</u>	<u>Name</u>
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Foreign Patent Documents

<u>Examiner Initial*</u>	<u>Document Number</u>	<u>Publication Date</u>	<u>Country or Patent Office</u>	<u>Translation</u>
_____ 1	10-123350	05/15/1998	Japan	No

Other Documents

(including author, title, pertinent pages, etc.)

<u>Examiner Initial*</u>

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| _____ 2 | T. Kitoh et al., <i>Low Chromatic-dispersion Flat-top Arrayed Waveguide Grating Filter</i> , Electronics Letters, Vol. 39, No. 15, July 24, 2003, pp. 1116-1118. |
| _____ 3 | Yabu Tetsuro et al., <i>New Design Method for Low Loss Y-Branch Waveguides</i> , Papers of Technical Meeting on Electromagnetic Theory, EMT, IEE Japan, EMT-00-29-40, May 19, 2000, pp. 65-71. |

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References Cited by Applicants

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The reference designations "A1," "A2," etc. (referring to Applicant's reference 1, Applicant's reference 2, etc.) will be used by the Examiner in the same manner as Examiner's reference designations "A," "B," "C," etc. on Office Action Form PTO-1142.

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